Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/679,054	Reexamination WOODRUFF ET	AL.
Examiner	Art Unit	
BIJENDRA K. SHRESTHA	3691	Page 1 of 1

U.S. PATENT DOCUMENTS

	U.S. PATENT DOCUMENTS				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2006/0218069	09-2006	Aberman et al.	705/037
*	В	US-2004/0133494	07-2004	Jones et al.	705/035
*	O	US-2003/0225656	12-2003	Aberman et al.	705/36
*	D	US-2008/0065529	03-2008	Bowen et al.	705/037
*	Е	US-2003/0182219	09-2003	Bodurtha et al.	705/36
*	F	US-2004/0153388	08-2004	Fisher et al.	705/036
*	G	US-6,263,321	07-2001	Daughtery, III, Vergil L.	705/36R
*	Н	US-2002/0133456	09-2002	Lancaster et al.	705/37
*	-	US-2002/0120542	08-2002	Higgins, Mark	705/36
*	٦	US-6,321,212	11-2001	Lange, Jeffrey	705/36R
*	К	US-2002/0103852	08-2002	Pushka, Wayne L.	709/203
*	L	US-2002/0138382	09-2002	Seaman, David A.	705/36
*	М	US-2002/0178111	11-2002	Woodley, John A.C.	705/38

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	т					

NON-PATENT DOCUMENTS

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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